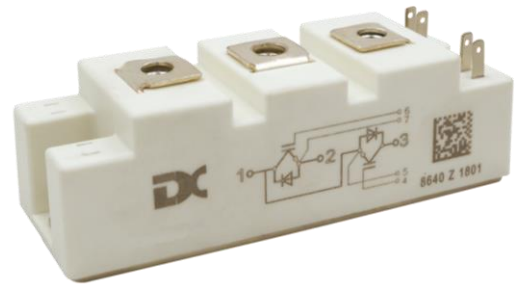


1200V/150A 2 in one-package

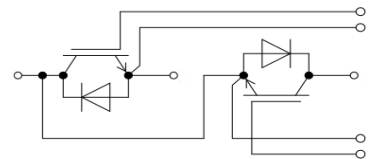
Features:

- 1200V150A, $V_{CE(sat)(typ)}=2.30V$
- SPT (Soft Punch Through) technology
- Lower losses
- Higher system efficiency
- Excellent short-circuit capability
- Square RBSOA



General Applications:

Daxin's IGBTs offer ultrafast switching speed for application such as welding, inductive heating, UPS and other high frequency applications



Equivalent Circuit Schematic

Absolute Maximum Ratings of IGBT

V_{CES}	Collector to Emitter Voltage		1200	V
V_{GES}	Continuous Gate to Emitter Voltage		± 30	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$	300	A
		$T_C = 100^\circ C$	150	
I_{CM}	Pulse Collector Current	$T_J = 150^\circ C$	300	A
P_D	Maximum Power Dissipation (IGBT)	$T_C = 25^\circ C, T_J = 150^\circ C$	500	W
t_{sc}	Short Circuit Withstand Time		> 10	μs
T_J	Maximum IGBT Junction Temperature		150	$^\circ C$
T_{JOP}	Maximum Operating Junction Temperature Range		-40 to +150	$^\circ C$
T_{stg}	Storage Temperature Range		-40 to +125	$^\circ C$

Absolute Maximum Ratings of Freewheeling Diode

V_{RRM}	Repetitive Peak Reverse Voltage Preliminary Data		1200	V
I_F	Diode Continuous Forward Current	$T_C = 25^\circ C$	300	A
		$T_C = 100^\circ C$	150	
I_{FM}	Diode Maximum Forward Current		300	A

Electrical Characteristics of IGBT at $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter		Test Conditions		Min	Typ	Max	Unit
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 1mA		1200			V
I _{CES}	Collector to Emitter Leakage Current	V _{GE} = 0V,V _{CE} = V _{CES}				1	mA
I _{GES}	Gate to Emitter Leakage Current	V _{GE} = ±30V, V _{CE} = 0V				200	nA
V _{GE(th)}	Gate Threshold Voltage	I _C = 1mA, V _{CE} = V _{GE}		4.5		5.7	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Module Level)	I _C = 150A, V _{GE} = 15V	T _J = 25°C		2.30	2.50	V
			T _J = 125°C		2.70		

Switching Characteristics of IGBT

$t_{d(on)}$	Turn-on Delay Time	$V_{CC} = 600V$ $I_C = 150A$ $R_G = 4.7\Omega$ $V_{GE} = \pm 15V$ Inductive Load	$T_J = 25^{\circ}C$		35		ns
			$T_J = 125^{\circ}C$		40		
t_r	Turn-on Rise Time		$T_J = 25^{\circ}C$		55		ns
			$T_J = 125^{\circ}C$		60		
$t_{d(off)}$	Turn-off Delay Time		$T_J = 25^{\circ}C$		340		ns
			$T_J = 125^{\circ}C$		370		
t_f	Turn-off Fall Time		$T_J = 25^{\circ}C$		90		ns
			$T_J = 125^{\circ}C$		120		
E_{on}	Turn-on Switching Loss		$T_J = 25^{\circ}C$		6.30		mJ
			$T_J = 125^{\circ}C$		8.00		
E_{off}	Turn-off Switching Loss		$T_J = 25^{\circ}C$		4.10		mJ
			$T_J = 125^{\circ}C$		7.20		
Q_g	Total Gate Charge		$T_J = 25^{\circ}C$		1140		nC
R_{gint}	Integrated gate resistor	$f = 1M;$ $V_{pp} = 1V$	$T_J = 25^{\circ}C$		2.5		Ω
C_{ies}	Input Capacitance	$V_{CE} = 25V$ $V_{GE} = 0V$ $f = 1MHz$	$T_J = 25^{\circ}C$		10.8		nF
C_{oes}	Output Capacitance		$T_J = 25^{\circ}C$		1.65		
C_{res}	Reverse Transfer Capacitance		$T_J = 25^{\circ}C$		0.94		
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (IGBT)					0.25	$^{\circ}C/W$

Electrical and Switching Characteristics of Freewheeling Diode

V _F	Diode Forward Voltage	I _F = 150A , V _{GE} = 0V	T _J = 25°C		1.90	2.20	V
			T _J = 125°C		1.90		
t _{rr}	Diode Reverse Recovery Time	I _F = 150A, di/dt=2600A/μs, V _{rr} = 600V,	T _J = 25°C		150		ns
			T _J = 125°C		200		
I _{rr}	Diode Peak Reverse Recovery Current		T _J = 25°C		165		A
			T _J = 125°C		190		
Q _{rr}	Diode Reverse Recovery Charge		T _J = 25°C		14.50		nC
			T _J = 125°C		21.00		
E _{rr}	Diode Reverse Recovery Energy		T _J = 25°C		4.50		mJ
			T _J = 125°C		7.30		
R _{θJC}	Thermal Resistance, Junction-to-Case (Diode)					0.38	°C/W

Module Characteristics

Parameter		Min.	Typ.	Max.	Unit
V_{iso}	Isolation Voltage (All Terminals Shorted), $f = 50Hz$, 1minute	2500			V
$R_{\theta CS}$	Case-To-Sink(Conductive Grease Applied)		0.1		$^\circ C/W$
M	Power Terminals Screw: M5	3.0		5.0	N·m
M	Mounting Screw: M6	4.0		6.0	N·m
G	Weight		160		g

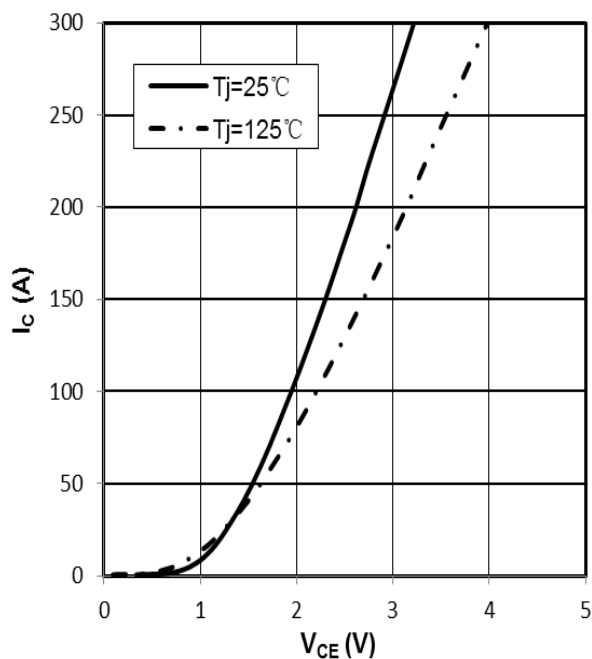


Fig 1. output characteristic IGBT,
 $I_c=f(V_{CE}), V_{GE}=15V$

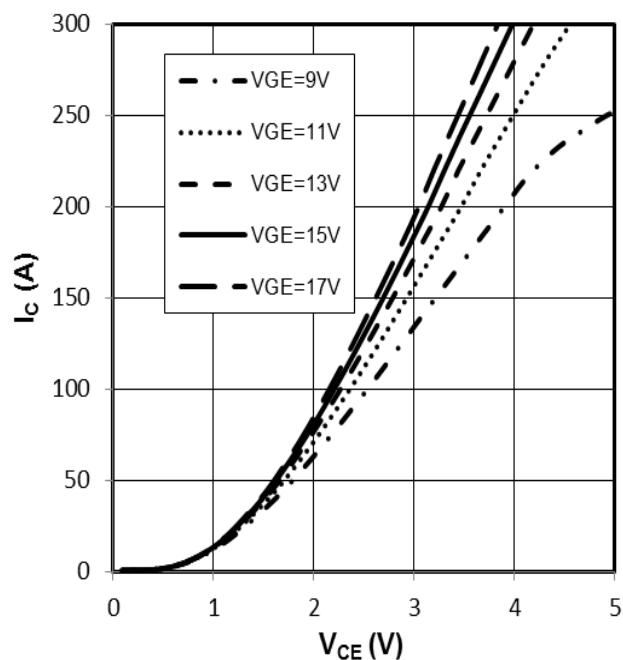


Fig 2. output characteristic IGBT,
 $I_c=f(V_{CE}), T_j=125^\circ C$

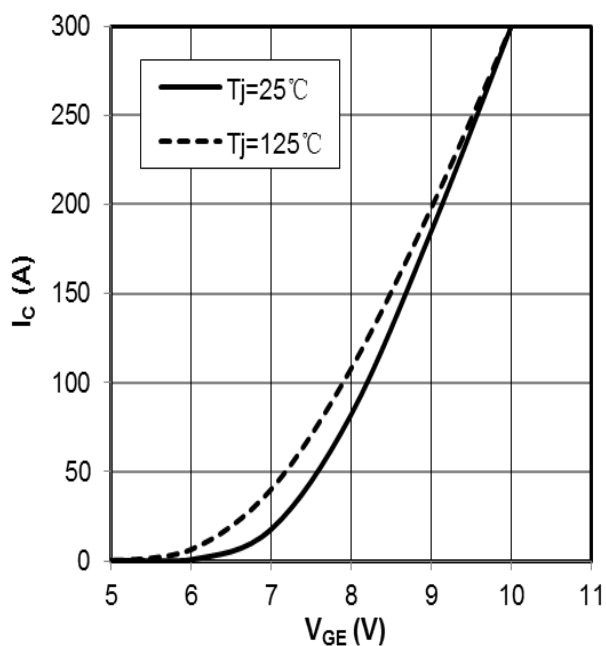


Fig 3. transfer characteristic IGBT,
 $I_c=f(V_{GE}), V_{CE}=20V$

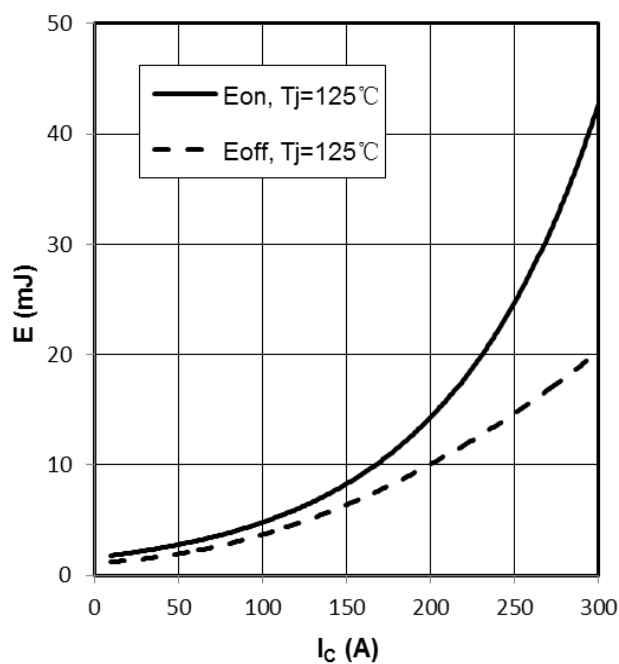


Fig 4. switching losses IGBT, $E_{on}=f(I_c), E_{off}=f(I_c)$,
 $V_{GE}=\pm 15V, R_{Gon}=4.7\Omega, R_{Goff}=4.7\Omega, V_{CE}=600V$

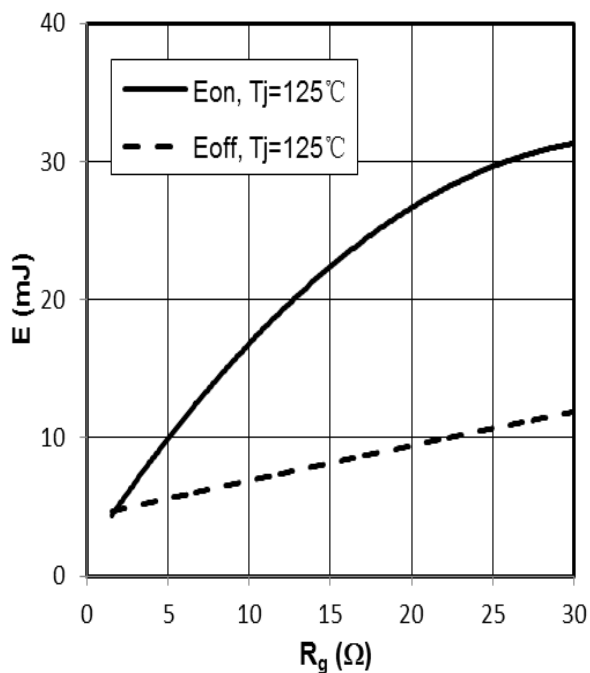


Fig 5. switching losses IGBT, $E_{on}=f(R_g)$, $E_{off}=f(R_g)$,
 $V_{GE}=\pm 15V$, $I_C=150A$, $V_{CE}=600V$

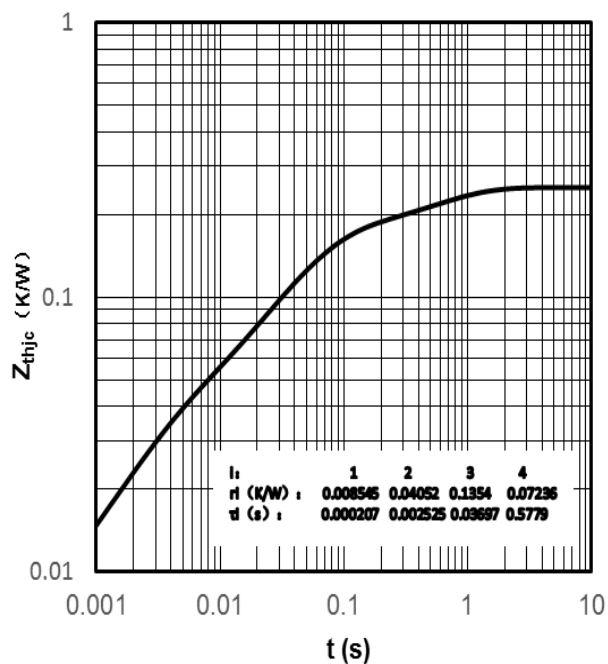


Fig 6. transient thermal impedance IGBT , $Z_{thjc}=f(t)$

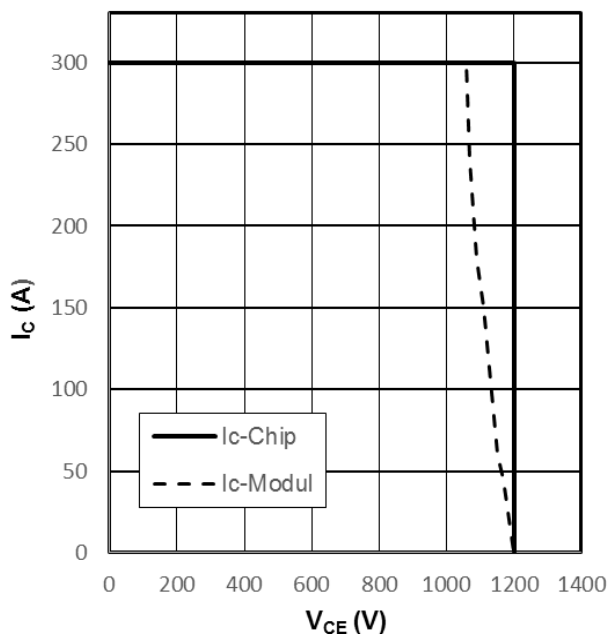


Fig 7. reverse bias safe operating area IGBT,
 $I_C=f(V_{CE})$, $V_{GE}=\pm 15V$, $R_{Goff}=4.7\Omega$, $T_{vj}=125^\circ C$

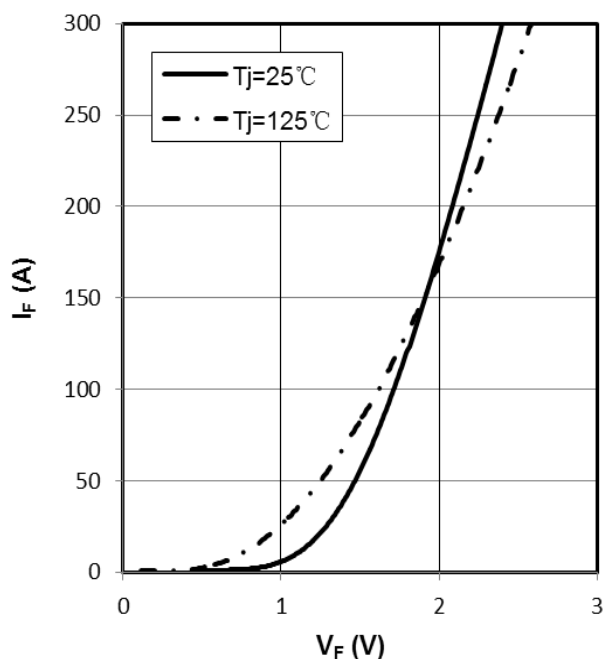


Fig 8. forward characteristic of Diode ,
 $I_F=f(V_F)$

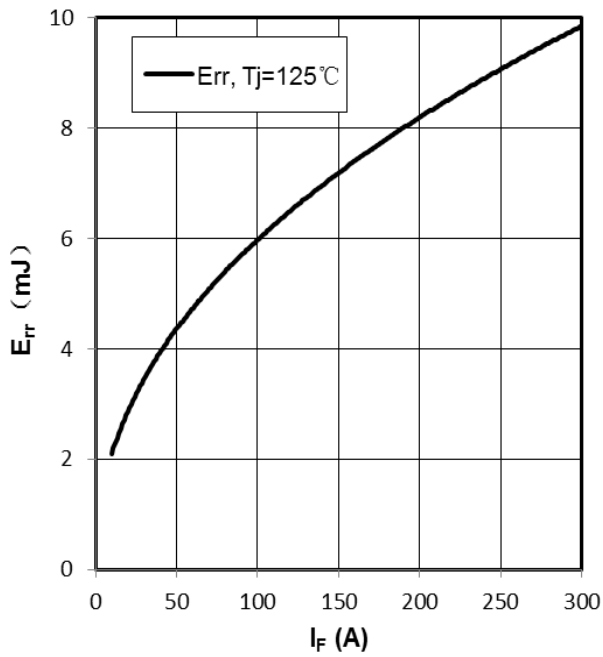


Fig 9. switching losses Diode,
 $E_{rr}=f(I_F)$, $R_{Gon}=4.7\Omega$, $V_{CE}=600V$

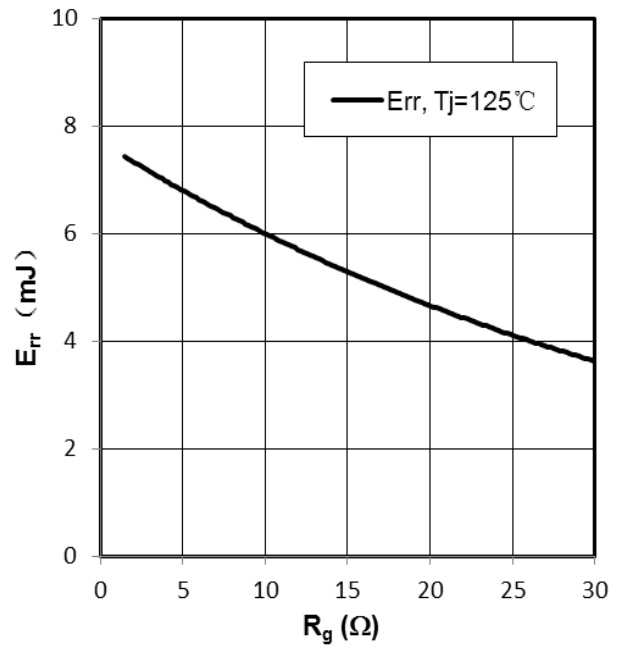
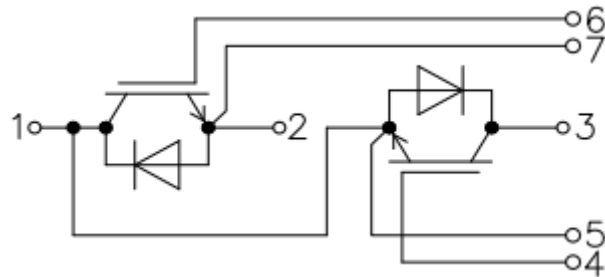


Fig 10. switching losses Diode,
 $E_{rr}=f(R_g)$, $I_F=150A$, $V_{CE}=600V$

Internal Circuit:



Package Dimension
Dimensions in Millimeters

